


<b>Search Notes</b> 	<b>Application/Control No.</b> 10566910	<b>Applicant(s)/Patent Under Reexamination</b> KRESSE ET AL.
	<b>Examiner</b> Randall Chin	<b>Art Unit</b> 3723

SEARCHED			
Class	Subclass	Date	Examiner
15	228	6/22/07	RC
15	229.4	6/22/07	RC
15	229.8	6/22/07	RC
updated search		4/30/08	RC
15	229.1	4/30/08	RC
15	229.2	4/30/08	RC
15	229.3	4/30/08	RC
15	229.5	4/30/08	RC
15	229.6	4/30/08	RC
15	229.7	4/30/08	RC
15	229.9	4/30/08	RC

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner